MT6025S5

60V Complementary Power MOSFET

Features

 N-Channel 60V/25A.

 $R_{DS}(ON)=25m\Omega$ @ VGS=10V

 $R_{DS}(ON)=32m_{\Omega}$ @ VGS=4.5V

P-Channel
 -60V/-30A,

 $R_{DS}(ON)=26m\Omega$ @ VGS=10V

 $R_{DS}(ON)=33m\Omega$ @ VGS=4.5V

RoHS Compliant

General Description

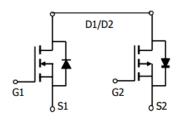
This complementary MOSFET device is produced using Mos-tech's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

Applications

- DC-DC converter
- · Power management
- · LCD backlight inverter

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N-channel

P-channel

MARKING DIAGRAM & PIN ASSIGNMENT

T0252-4L

Top View Bottom View
D1/D2
D1/D2
S2 G2

Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		N-CH	P-CH	Units
V _{DSS}	Drain-Source Voltage		60 -60		V
V _{GSS}	Gate-Source Voltage		±20	±20	V
I _D	Drain Current - Continuous	(Note 1a)	25	-30	
	- Pulsed		29	-35	A
P _D	Power Dissipation for Dual Operation		4.		
	Power Dissipation for Single Operation	(Note 1a)	2.0		
		(Note 1b)		6	- w
	(Note 1c		2.		
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to	°C	

Thermal Characteristics

R _{θJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	79	°C/W
R _{θJC}	Thermal Resistance, Junction-to-Case	(Note 1)	41	°C/W

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Electrical Characteristics T_A = 25°C unless otherwise noted

Symbo	I Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Drain-Sc	ource Avalanche Ratings	S (Note 1)			•	•	•
W _{DSS}	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 30 \text{ V}, \qquad I_{D} = 4.5 \text{ A}$	N-CH			35	mJ
I _{AR}	Maximum Drain-Source Avalanche Current		N-CH			19	Α
Off Chai	racteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	N-CH P-CH	60 -60			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C I_D = –250 μA, Referenced to 25°C	N-CH P-CH		59 –47		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =20V,V _{GS} = 0 V V _{DS} =-20V,V _{GS} = 0 V	N-CH P-CH			1 -1	μА
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	N-CH P-CH			<u>+</u> 100 <u>+</u> 100	nA
On Char	acteristics (Note 2)						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$ $V_{DS} = V_{GS}, I_D = -250 \mu A$	N-CH P-CH	1 –1	1.5 -1.7	2.5 -2.5	V
$\Delta V_{GS(th)} \over \Delta T_{J}$	Gate Threshold Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C I _D = –250 μA, Referenced to 25°C	N-CH P-CH		-5.6 4		mV/°C
_	Static Drain-Source	V _{GS} = 10 V, I _D = 3.0A V _{GS} = 4.5 V, I _D = 2.0A	N-CH		25 32	36 45	mΩ
R _{DS(on)}	On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -3.0 \text{A}$ $V_{GS} = -4.5 \text{ V}, I_D = -2.0 \text{A}$	P-CH		26 33	35 46]
I _{D(on)}	On-State Drain Current	V _{GS} = 10 V, V _{DS} = 5 V V _{GS} = -10 V, V _{DS} = -5 V	N-CH P-CH	25 -30	00	10	А
g FS	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_D = 4.5 \text{ A}$ $V_{DS} = -5 \text{ V}, I_D = -3.5 \text{ A}$	N-CH P-CH		15 10		S
Dvnamio	Characteristics						
C _{iss}	Input Capacitance	N-CH V _{DS} = 55 V,V _{GS} = 0 V,	N-CH P-CH		690 800		pF
C _{oss}	Output Capacitance	f = 1.0 MHz P-CH	N-CH P-CH		88 96		pF
C _{rss}	Reverse Transfer Capacitance	V_{DS} =-55 V,V $_{GS}$ = 0 V, f = 1.0 MHz	N-CH P-CH		38 40		pF
Switchin	g Characteristics (Note 2)						
t _{d(on)}	Turn-On Delay Time	N-CH V _{DD} = 60 V,I _D = 1 A,	N-CH P-CH		15 7	25 17	ns
t _r	Turn-On Rise Time	$V_{GS} = 10 \text{ V,R}_{GEN} = 6 \Omega$	N-CH P-CH		9	22 26	ns
t _{d(off)}	Turn-Off Delay Time	P-CH V _{DD} = -60 V,I _D = -1 A,	N-CH P-CH		19 19	42 37	ns
t _f	Turn-Off Fall Time	$V_{GS} = -10 \text{ V}, R_{GEN} = 6 \Omega$	N-CH P-CH		8 12	18 25	ns
Qg	Total Gate Charge	N-CH V _{DS} = 60 V,I _D = 4.5 A, V _{GS} = 10 V	N-CH P-CH		15.5 18	22 24	nC
Q _{gs}	Gate-Source Charge	P-CH	N-CH P-CH		2.6 2.7		nC
Q_{gd}	Gate-Drain Charge	$V_{DS} = -60 \text{ V,I}_{D} = -3.5 \text{ A, } V_{GS} = -10 \text{V}$	N-CH P-CH		2.7		nC

Electrical Characteristics (continued) T_A = 25°C unless otherwise noted Symbol **Parameter Test Conditions** Type Min Тур Max Units **Drain-Source Diode Characteristics and Maximum Ratings** Maximum Continuous Drain-Source Diode Forward Current N-CH 1.3 Α P-CH -1.3 Drain-Source Diode Forward | V_{GS} = 0 V, I_S = 1.3 A (Note 2) V_{SD} N-CH 0.8 1.1 ٧ Voltage $V_{GS} = 0 \text{ V}, I_{S} = -1.3 \text{ A}$ (Note 2)

R_{BJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of
the drain pins. R_{BJC} is guaranteed by design while R_{BCA} is determined by the user's board design.



a) 78°C/W when mounted on a 0.5 in² pad of 2 oz copper



b) 125°C/W when mounted on a .02 in² pad of 2 oz copper



P-CH

c) 135°C/W when mounted on a minimum pad.

-0.8

-1.1

Scale 1: 1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

Typical Characteristics: P-CH

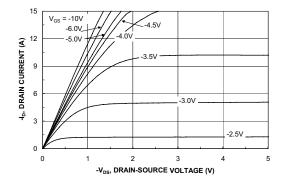


Figure 1. On-Region Characteristics.

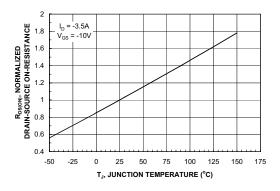


Figure 3. On-Resistance Variation with Temperature.

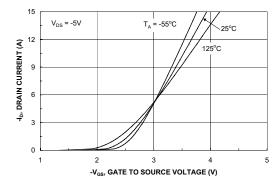


Figure 5. Transfer Characteristics.

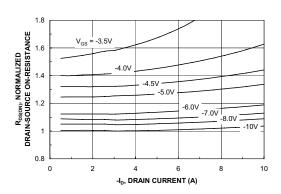


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

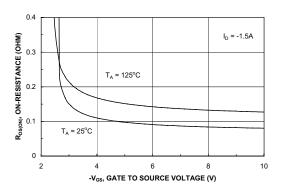


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

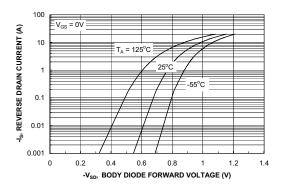


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: P-CH

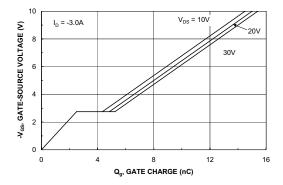


Figure 7. Gate Charge Characteristics.

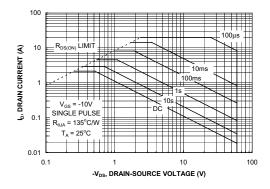


Figure 9. Maximum Safe Operating Area.

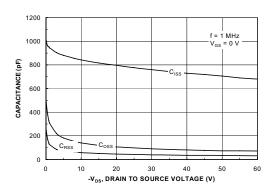


Figure 8. Capacitance Characteristics.

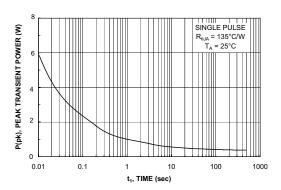


Figure 10. Single Pulse Maximum Power Dissipation.

Typical Characteristics: N-CH

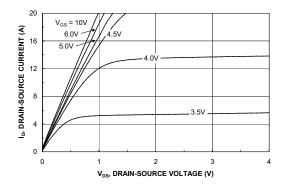


Figure 11. On-Region Characteristics.

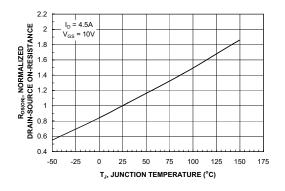


Figure 13. On-Resistance Variation with Temperature.

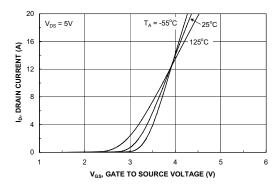


Figure 15. Transfer Characteristics.

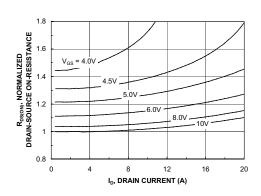


Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.

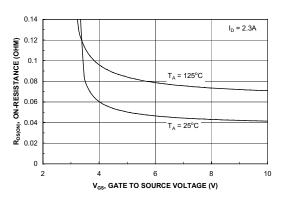


Figure 14. On-Resistance Variation with Gate-to-Source Voltage.

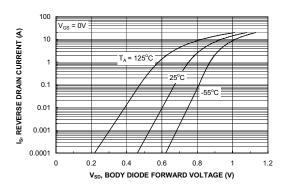
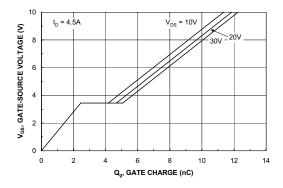


Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

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Typical Characteristics: N-CH



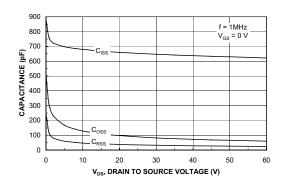


Figure 17. Gate Charge Characteristics.

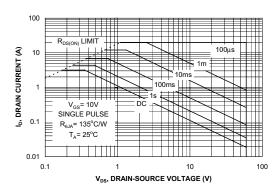


Figure 18. Capacitance Characteristics.

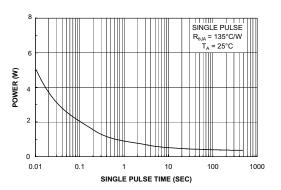


Figure 19. Maximum Safe Operating Area.



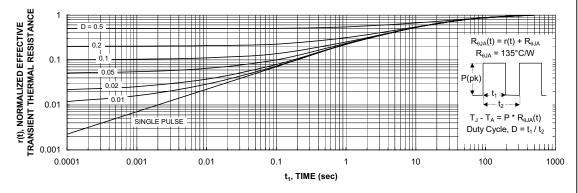
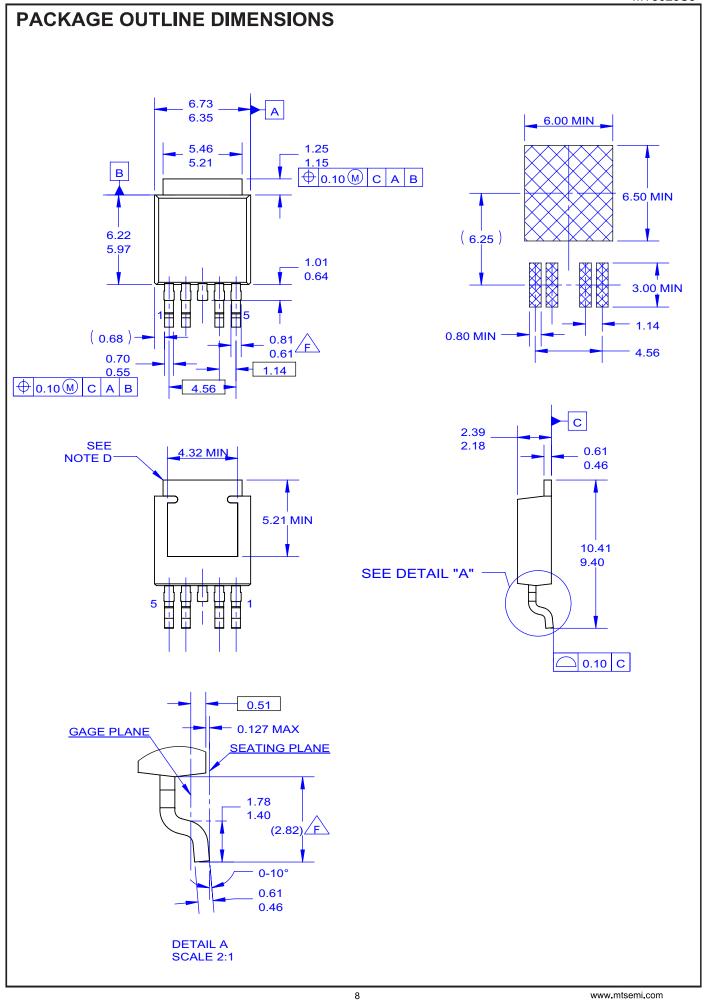


Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.



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